Murata
Manufacturing Co., Ltd.

#### Part Numbering

Chip Monolithic Ceramic Capacitors

GR M 18 8 B1 1H 102 K A01 D (Part Number)

#### Product ID

#### 2Series

Product ID	Code	Series	
	J	Soft Termination Type	
GR	М	Tin Plated Layer	
GK	4	Only for Information Devices / Tip & Ring	
	7	Only for Camera Flash Circuit	
GQ	M	High Frequency for Flow/Reflow Soldering	
GM	Α	Monolithic Microchip	
GIVI	D	For Bonding	
GN	М	Capacitor Array	
	L	Low ESL Type	
LL	R	Controlled ESR Low ESL Type	
LL	A	8-termination Low ESL Type	
	M	10-termination Low ESL Type	
GJ	M	High Frequency Low Loss Type	
	2	For AC250V (r.m.s.)	
GA	3	Safety Standard Certified Type	

#### 3Dimensions (LXW)

Code	Dimensions (LXW)	EIA
02	0.4×0.2mm	01005
03	0.6×0.3mm	0201
05	0.5×0.5mm	0202
08	0.8×0.8mm	0303
0D	0.38×0.38mm	015015
ОМ	0.9×0.6mm	0302
15	1.0×0.5mm	0402
18	1.6×0.8mm	0603
1M	1.37×1.0mm	0504
21	2.0×1.25mm	0805
22	2.8×2.8mm	1111
31	3.2×1.6mm	1206
32	3.2×2.5mm	1210
42	4.5×2.0mm	1808
43	4.5×3.2mm	1812
52	5.7×2.8mm	2211
55	5.7×5.0mm	2220

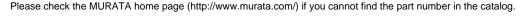
#### Dimension (T) (Except GNM)

- ,,,	• •
Code	Dimension (T)
2	0.2mm
3	0.3mm
5	0.5mm
6	0.6mm
7	0.7mm
8	0.8mm
9	0.85mm
Α	1.0mm
В	1.25mm
С	1.6mm
D	2.0mm
E	2.5mm
F	3.2mm
M	1.15mm
N	1.35mm
Q	1.5mm
R	1.8mm
s	2.8mm
Х	Depends on individual standards.
	· · · · · · · · · · · · · · · · · · ·

#### **4** Elements (**GNM** Only)

Code	Elements
2	2-elements
4	4-elements







 $\begin{tabular}{|c|c|c|c|}\hline \end{tabular}$  Continued from the preceding page.

**5**Temperature Characteristics

Temperature Characteristic Codes		odes		Operating			
Code	Public STD	Code	Reference Temperature	Temperature Range	Capacitance Change or Temperature Coefficient	Temperature Range	
1X	SL *1	JIS	20°C	20 to 85°C	+350 to -1000ppm/°C	-55 to 125°C	
2C	CH *1	JIS	20°C	20 to 125°C	0±60ppm/°C	-55 to 125°C	
2P	PH *1	JIS	20°C	20 to 85°C	-150±60ppm/°C	-25 to 85°C	
2R	RH *1	JIS	20°C	20 to 85°C	-220±60ppm/°C	-25 to 85°C	
2S	SH *1	JIS	20°C	20 to 85°C	-330±60ppm/°C	-25 to 85°C	
2T	TH *1	JIS	20°C	20 to 85°C	-470±60ppm/°C	-25 to 85°C	
3C	CJ *1	JIS	20°C	20 to 125°C	0±120ppm/°C	-55 to 125°C	
3P	PJ *1	JIS	20°C	20 to 85°C	-150±120ppm/°C	-25 to 85°C	
3R	RJ *1	JIS	20°C	20 to 85°C	-220±120ppm/°C	-25 to 85°C	
3S	SJ *1	JIS	20°C	20 to 85°C	-330±120ppm/°C	-25 to 85°C	
3T	TJ *1	JIS	20°C	20 to 85°C	-470±120ppm/°C	-25 to 85°C	
3U	UJ *1	JIS	20°C	20 to 85°C	-750±120ppm/°C	-25 to 85°C	
4C	CK *1	JIS	20°C	20 to 125°C	0±250ppm/°C	-55 to 125°C	
5C	C0G *1	EIA	25°C	25 to 125°C	0±30ppm/°C	-55 to 125°C	
5G	X8G *1	EIA	25°C	25 to 150°C	0±30ppm/°C	-55 to 150°C	
6C	C0H *1	EIA	25°C	25 to 125°C	0±60ppm/°C	-55 to 125°C	
6P	P2H *1	EIA	25°C	25 to 85°C	-150±60ppm/°C	-55 to 125°C	
6R	R2H *1	EIA	25°C	25 to 85°C	-220±60ppm/°C	-55 to 125°C	
6S	S2H *1	EIA	25°C	25 to 85°C	-330±60ppm/°C	-55 to 125°C	
6T	T2H *1	EIA	25°C	25 to 85°C	-470±60ppm/°C	-55 to 125°C	
7U	U2J *1	EIA	25°C	25 to 125°C *6	-750±120ppm/°C	-55 to 125°C	
B1	B *2	JIS	20°C	-25 to 85°C	±10%	-25 to 85°C	
В3	В	JIS	20°C	-25 to 85°C	±10%	-25 to 85°C	
<b>C</b> 7	X7S	EIA	25°C	-55 to 125°C	±22%	-55 to 125°C	
C8	X6S	EIA	25°C	-55 to 105°C	±22%	-55 to 105°C	
D7	X7T	EIA	25°C	-55 to 125°C	+22, -33%	-55 to 125°C	
D8	X6T	EIA	25°C	-55 to 105°C	+22, -33%	-55 to 105°C	
E7	X7U	EIA	25°C	-55 to 125°C	+22, -56%	-55 to 125°C	
F1	F *2	JIS	20°C	-25 to 85°C	+30, -80%	-25 to 85°C	
F5	Y5V	EIA	25°C	-30 to 85°C	+22, -82%	-30 to 85°C	
L8	X8L	*3	25°C	-55 to 150°C	+15, -40%	-55 to 150°C	
R1	R *2	JIS	20°C	-55 to 125°C	±15%	-55 to 125°C	
R3	R	JIS	20°C	-55 to 125°C	±15%	-55 to 125°C	
R6	X5R	EIA	25°C	-55 to 85°C	±15%	-55 to 85°C	
R7	X7R	EIA	25°C	-55 to 125°C	±15%	-55 to 125°C	
R9	X8R	EIA	25°C	-55 to 150°C	±15%	-55 to 150°C	
14/0			2500	FF to 12F9C	±10% *4	FF 1 40500	
<b>W0</b> - 25°C -55 to 125°C +22, -33% *5	, 22 220/ *5	-55 to 125°C					

<sup>\*1</sup> Please refer to table for Capacitance Change under reference temperature.

Continued on the following page.





Please check the MURATA home page (http://www.murata.com/) if you cannot find the part number in the catalog.

<sup>\*2</sup> Capacitance change is specified with 50% rated voltage applied.

<sup>\*3</sup> Murata Temperature Characteristic Code.

<sup>\*4</sup> Apply DC350V bias.

<sup>\*5</sup> No DC bias.

<sup>\*6</sup> Rated Voltage 100Vdc max : 25 to 85°C

Continued from the preceding page.

#### ●Capacitance Change from each temperature

#### JIS Code

	Capacitance Change from 20°C (%)						
Murata Code	–55°C		−25°C		−10°C		
	Max.	Min.	Max.	Min.	Max.	Min.	
1X	-	-	-	-	-	-	
2C	0.82	-0.45	0.49	-0.27	0.33	-0.18	
2P	-	-	1.32	0.41	0.88	0.27	
2R	-	-	1.70	0.72	1.13	0.48	
28	-	-	2.30	1.22	1.54	0.81	
2T	-	-	3.07	1.85	2.05	1.23	
3C	1.37	-0.90	0.82	-0.54	0.55	-0.36	
3P	-	-	1.65	0.14	1.10	0.09	
3R	-	-	2.03	0.45	1.35	0.30	
38	-	-	2.63	0.95	1.76	0.63	
3T	-	-	3.40	1.58	2.27	1.05	
3U	-	-	4.94	2.84	3.29	1.89	
4C	2.56	-1.88	1.54	-1.13	1.02	-0.75	

#### EIA Code

	Capacitance Change from 25°C (%)						
Murata Code	-55°C		−30°C		–10°C		
	Max.	Min.	Max.	Min.	Max.	Min.	
5C/5G	0.58	-0.24	0.40	-0.17	0.25	-0.11	
6C	0.87	-0.48	0.59	-0.33	0.38	-0.21	
6P	2.33	0.72	1.61	0.50	1.02	0.32	
6R	3.02	1.28	2.08	0.88	1.32	0.56	
6S	4.09	2.16	2.81	1.49	1.79	0.95	
6T	5.46	3.28	3.75	2.26	2.39	1.44	
7U	8.78	5.04	6.04	3.47	3.84	2.21	

#### 6 Rated Voltage

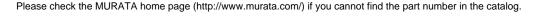
Code	Rated Voltage
	•
0E	DC2.5V
0G	DC4V
0J	DC6.3V
1A	DC10V
1C	DC16V
1E	DC25V
YA	DC35V
1H	DC50V
2A	DC100V
2D	DC200V
2E	DC250V
YD	DC300V
2H	DC500V
2J	DC630V
3A	DC1kV
3D	DC2kV
3F	DC3.15kV
ВВ	DC350V (for Camera Flash Circuit)
E2	AC250V
GC	X1/Y2; AC250V (Safety Standard Certified Type GC)
GF	Y2, X1/Y2; AC250V (Safety Standard Certified Type GF)
GD	Y3; AC250V (Safety Standard Certified Type GD)
GB	X2; AC250V (Safety Standard Certified Type GB)

#### Capacitance

Expressed by three-digit alphanumerics. The unit is picofarad (pF). The first and second figures are significant digits, and the third figure expresses the number of zeros which follow the two numbers.If there is a decimal point, it is expressed by the capital letter "R." In this case, all figures are significant digits.

Ex.)	Code	Capacitance
	R50	0.5pF
	1R0	1.0pF
	100	10pF
	103	10000pF





Continued from the preceding page.

#### Capacitance Tolerance

Code	Capacitance Tolerance	TC	Series	Ca	pacitance Step	
w	±0.05pF	СΔ	GRM/GJM	≦9.9pF	0.1pF	
			GRM/GJM	≦9.9pF	0.1pF	
В	±0.1pF	СΔ	GQM	≦1pF	0.1pF	
			GQW	1.1 to 9.9pF	1pF Step and E24 Series	
		СΔ	GRM/GJM	≦9.9pF	0.1pF	
С	±0.25pF	except C∆	GRM	≦5pF	* 1pF	
C	_0.25με	СД	GQM	≦1pF	0.1pF	
		CA	GQW	1.1 to 9.9pF	1pF Step and E24 Series	
		СΔ	GRM/GJM	5.1 to 9.9pF	0.1pF	
D	±0.5pF	except C∆	GRM	5.1 to 9.9pF	* 1pF	
		СΔ	GQM	5.1 to 9.9pF	1pF Step and E24 Series	
G	±2%	СΔ	GJM	≧10pF	E12 Series	
	1270	СΔ	GQM	≧10pF	E24 Series	
J	±5%	CΔ, SL, U2J	GRM/GA3	≧10pF	E12 Series	
<u> </u>	15%	СΔ	GQM/GJM	≧10pF	E24 Series	
		B, R, X7R, X5R, ZLM	GRJ/GRM/GR7/GA3		E6 Series	
K	±10%	C0G	GNM		E6 Series	
		B, R, X7R, X5R, ZLM	GR4, GMD		E12 Series	
		B, R, X7R, X7S	GRM/GMA		E6 Series	
М	±20%	X5R, X7R, X7S	GNM	E3 Series		
IVI	12076	X7R	GA2		E3 Series	
		X5R, X7R, X7S, X6S	LLL/LLR/LLA/LLM		E3 Series	
Z	+80%, -20%	F, Y5V	GRM	E3 Series		
R	Depends on individual standards.					

<sup>\*</sup> E24 series is also available.

#### 9Individual Specification Code (Except LLR)

Expressed by three figures.

#### **9**ESR (**LLR** Only)

Code	ESR
E01	100mΩ
E03	220mΩ
E05	470mΩ
E07	1000mΩ

#### Packaging

Code	Packaging
L	ø180mm Embossed Taping
D	ø180mm Paper Taping
E	ø180mm Paper Taping (LLL15)
K	ø330mm Embossed Taping
J	ø330mm Paper Taping
F	ø330mm Paper Taping (LLL15)
В	Bulk
С	Bulk Case
Т	Bulk Tray

Please check the MURATA home page (http://www.murata.com/) if you cannot find the part number in the catalog.



# **Chip Monolithic Ceramic Capacitors (Medium Voltage)**



### For Information Devices GR4 Series

#### ■ Features

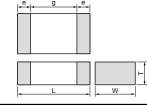
- These items are designed specifically for telecommunications devices (IEEE802.3) in Ethernet LAN and primary-secondary coupling for DC-DC converters.
- A new monolithic structure for small, high capacitance capable of operating at high voltage levels
- Sn-plated external electrodes realize good solderability.
- 4. Only for reflow soldering

#### ■ Applications

- Ideal for use on telecommunications devices in Ethernet LAN
- Ideal for use as primary-secondary coupling for DC-DC converters

Do not use these products in any Automotive
Power train or Safety equipment including Battery
charger for Electric Vehicles and Plug-in Hybrid.
Only Murata products clearly stipulated as
"for Automotive use" can be used for automobile
applications such as Power train and Safety equipment.





Part Number	Dimensions (mm)						
Part Number	L	W	Т	e min.	g min.		
GR442Q	4.5 ±0.3	2.0 ±0.2	1.5 +0, -0.3				
GR443D	4.5 ±0.4	3.2 ±0.3	2.0 +0, -0.3	0.3	2.5		
GR443Q			1.5 +0, -0.3	0.3			
GR455D	5.7 ±0.4	5.0 ±0.4	2.0 +0, -0.3		3.2		

Part Number Rated Voltage TC Code (V) (Standard)		Capacitance (pF)	Length L (mm)	Width W (mm)	Thickness T (mm)	Electrode g min. (mm)	Electrode e (mm)	
GR442QR73D101KW01L	DC2000	X7R (EIA)	100 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GR442QR73D121KW01L	DC2000	X7R (EIA)	120 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GR442QR73D151KW01L	DC2000	X7R (EIA)	150 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GR442QR73D181KW01L	DC2000	X7R (EIA)	180 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GR442QR73D221KW01L	DC2000	X7R (EIA)	220 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GR442QR73D271KW01L	DC2000	X7R (EIA)	270 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GR442QR73D331KW01L	DC2000	X7R (EIA)	330 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GR442QR73D391KW01L	DC2000	X7R (EIA)	390 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GR442QR73D471KW01L	DC2000	X7R (EIA)	470 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GR442QR73D561KW01L	DC2000	X7R (EIA)	560 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GR442QR73D681KW01L	DC2000	X7R (EIA)	680 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GR442QR73D821KW01L	DC2000	X7R (EIA)	820 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GR442QR73D102KW01L	DC2000	X7R (EIA)	1000 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GR442QR73D122KW01L	DC2000	X7R (EIA)	1200 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GR442QR73D152KW01L	DC2000	X7R (EIA)	1500 ±10%	4.5	2.0	1.5	2.5	0.3 min.
GR443QR73D182KW01L	DC2000	X7R (EIA)	1800 ±10%	4.5	3.2	1.5	2.5	0.3 min.
GR443QR73D222KW01L	DC2000	X7R (EIA)	2200 ±10%	4.5	3.2	1.5	2.5	0.3 min.
GR443QR73D272KW01L	DC2000	X7R (EIA)	2700 ±10%	4.5	3.2	1.5	2.5	0.3 min.
GR443QR73D332KW01L	DC2000	X7R (EIA)	3300 ±10%	4.5	3.2	1.5	2.5	0.3 min.
GR443QR73D392KW01L	DC2000	X7R (EIA)	3900 ±10%	4.5	3.2	1.5	2.5	0.3 min.
GR443DR73D472KW01L	DC2000	X7R (EIA)	4700 ±10%	4.5	3.2	2.0	2.5	0.3 min.
GR455DR73D103KW01L	DC2000	X7R (EIA)	10000 ±10%	5.7	5.0	2.0	3.2	0.3 min.

# **GR4 Series Specifications and Test Methods**

No.	Ite	m	Specifications	Test Method				
1	Operating Temperatu	re Range	−55 to +125°C	-				
2	Appearan	ce	No defects or abnormalities	Visual inspection				
3	Dimension	ns	Within the specified dimensions	Using calipers and	micrometers			
4	Dielectric Strength		No defects or abnormalities	No failure should be observed when voltage in the table is applied between the terminations, provided the charge/discharge current is less than 50mA.				
				Rated Voltage DC2kV	Test Voltage 120% of the rated voltage	Time 60±1 sec.		
					AC1500V(r.m.s.)	60±1 sec.		
5	Pulse Volt	tage	No self healing breakdowns or flash-overs have taken place in the capacitor.	10 impulses of alternating polarity are subjected. (5 impulses for each polarity) The interval between impulses is 60 sec. Applied Pulse: 1.2/50μs Applied Voltage: 2.5kVo-p				
6	Insulation R (I.R.)	Resistance	More than $6{,}000M\Omega$	The insulation resistance should be measured with DC500±50V and within 60±5 sec. of charging.				
7	Capacitar	nce	Within the specified tolerance	The conscitones/D	C should be messured at a	fraguana, of		
8	Dissipatio Factor (D.		0.025 max.	The capacitance/D.F. should be measured at a frequency of 1±0.2kHz and a voltage of AC1±0.2V(r.m.s.)				
9	Capacitance 9 Temperature Characteristics		Cap. Change within ±15% (Temp. Range: −55 to +125°C)	The capacitance measurement should be made at each step specified in the Table.  Step Temperature (°C)  1 25±2 2 Min. Operating Temp.±3 3 25±2 4 Max. Operating Temp.±2 5 25±2  • Pretreatment Perform a heat treatment at 150 <sup>+0</sup> / <sub>-10</sub> °C for 60±5 min. and then let sit for 24±2 hrs. at room condition.*				
10	Adhesive Strength of Termination		No removal of the terminations or other defect should occur.	Solder the capacito in Fig. 1. Then apply 10N for The soldering shou should be conducte and free of defects	w. nethod and			
		Appearance	No defects or abnormalities		r to the test jig (glass epoxy l	,		
		Capacitance	Within the specified tolerance	•	ld be subjected to a simple h itude of 1.5mm, the frequenc			
11	Vibration Resistance			uniformly between the approximate limits of 10 and 55Hz. The frequency range, from 10 to 55Hz and return to 10Hz, should be traversed in approximately 1 min. This motion should be applied for a period of 2 hrs. in each of 3 mutually perpendicular directions (total of 6 hrs.).  Solder resist  Glass Epoxy Board				

<sup>\* &</sup>quot;Room condition" Temperature: 15 to 35℃, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa





### **GR4 Series Specifications and Test Methods**

Continued from the preceding page.

7	Continued from the preceding page.										
No.	Ite	em	Specifications						Test Method		
12	12 Deflection		LXW (mm) 4.5×2.0 4.5×3.2 5.7×5.0	a 3.5 3.5 4.5	Fig. 2  Dimensi  b  7.0  7.0  8.0	04.5 t:1.6	d 1.0	Solder the capacitor to the testing jig (glass epoxy board) show in Fig. 2.  Then apply a force in the direction shown in Fig. 3.  The soldering should be done using the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock.  20 50 Pressurizing speed: 1.0mm/s speed: 1.0			
13	Solderabi Terminati	•	75% of the terminations are to be soldered evenly and continuously.					Immerse in solder solution for 2±0.5 sec. Immersing speed: 25±2.5mm/s Temp. of solder: 245±5°C Lead Free Solder (Sn-3.0Ag-0.5Cu) 235±5°C H60A or H63A Eutectic Solder			
		Appearance	No marking defe	ects				Preheat the capacitor as in table.  Immerse the capacitor in solder solution at 260±5°C for 10±1			
		Capacitance Change	Within ±10%					sec. Let sit at room condition* for 24±2 hrs., then measure.  •Immersing speed: 25±2.5mm/s  •Pretreatment  Perform a heat treatment at 150±18°C for 60±5 min. and then let sit for 24±2 hrs. at room condition.*			
	Resistance	D.F.	0.025 max.								
14	to Soldering	I.R.	More than 1,000	ΩΜΩ							
	Heat	Dielectric Strength	In accordance w	vith item No	o.4			*Preheating  Step  1 2	Temperature 100 to 120°C 170 to 200°C	Time 1 min. 1 min.	
		Appearance	No marking defe	ects				Fix the capac	itor to the supporting jig (glass	epoxy board) shown	
		Capacitance Change	Within ±15%					in Fig. 4. Perform the 5 cycles according to the 4 heat treatments listed in the following table.			
		D.F.	0.05 max.					Let sit for 24±2 hrs. at room condition,* then measure.			
		I.R.	More than 3,000	ΟΜΩ				Step 1	Temperature (°C) Min. Operating Temp.±3	Time (min.) 30±3	
								2	Room Temp.	2 to 3	
								3 4	Max. Operating Temp.±2  Room Temp.	30±3 2 to 3	
15	Temperature Cycle	Dielectric Strength	In accordance with item No.4			•Pretreatment Perform a heat treatment at 150 <sup>±</sup> 10°C for 60±5 min. and then let sit for 24±2 hrs. at room condition.*  Solder resist Cu Glass Epoxy Board  Fig. 4					
		Appearance	No marking defe	ects				-			
	Humidity	Capacitance Change	Within ±15%					for 500 <sup>+2</sup> 6hr	itor sit at 40±2°C and relative ss. let sit for 24±2 hrs. at room of	•	
16	(Steady	D.F.	0.05 max.					measure.	31. 101 2 T. 2 1113. at 100111 t	odiaon, uton	
	State)	I.R.	More than 1,000M $\Omega$					•Pretreatment Perform a heat treatment at 150 <sup>±</sup> -18°C for 60±5 min. and then			
		Dielectric Strength	In accordance w	vith item No	0.4				E2 hrs. at room condition.*	OO TO HIIII. AND UICH	

<sup>\* &</sup>quot;Room condition" Temperature: 15 to 35°C, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa

Strength





# **GR4 Series Specifications and Test Methods**

Continued from the preceding page.

No.	Ite	m	Specifications	Test Method			
		Appearance	No marking defects				
		Capacitance Change	Within ±20%	Apply 110% of the rated voltage for 1,000 <sup>±48</sup> hrs. at maximum operating temperature ±3°C. Remove and let sit for 24±2 hrs. at room condition,* then measure.			
17	Life	D.F.	0.05 max.	The charge/discharge current is less than 50mA.			
		I.R.	More than $2,000M\Omega$	Pretreatment     Apply test voltage for 60±5 min. at test temperature.			
		Dielectric Strength	In accordance with item No.4	Remove and let sit for 24±2 hrs. at room condition.*			

<sup>\* &</sup>quot;Room condition" Temperature: 15 to 35°C, Relative humidity: 45 to 75%, Atmospheric pressure: 86 to 106kPa

